FORM PTO-1449 (REV. 7-85)

EXAMINER

U.S. DEPAF OF COMMERCE PATENT AN ADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

(Use s veral sheets if necessary)

Sheet 1 of 2

ATTY. DOT NO.
LA29 NP
APPLICATION NO.
09/664,509 /0/08°, 9 65
APPLICANT
CHENG ET AL.
FILING DATE
SEPTEMBER 18, 2000 2/22/02



U.S. PATENT DOCUMENTS EXAMINER INITIAL **DOCUMENT NUMBER** DATE NAME CLASS SUBCLASS FILING DATE AA AB AC AD AE **AF** AG AH Αl AJ ΑK AL **FOREIGN PATENT DOCUMENTS** TRANSLATION YES NO **DOCUMENT NUMBER** DATE **OFFICE CLASS SUBCLASS AM** WO99/11255 3/11/99 **PCT-with English translation** AN WO96/38415 12/5/96 **PCT-with English Abstract** AO WO98/00403 1/8/98 **PCT** AP WO98/00137 1/8/98 PCT AQ WO97/31907 9/4/97 **PCT** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.) Collins, et al, J. Med. Chem., 41, 5037-5054, 1998 AR Henke, et al, J. Med. Chem., 41, 5020-5036, 1998 **AS** Cobb, et al, J. Med. Chem., 41, 5055-5069, 1998 **AT**

*EXAMINER: Initial f ref rence considered, whether or not citation is in conformance with MPEP 609: Draw a lin through citation if not in conformance and not considered. Include a copy of this form with the next communication t applicant.

DATE CONSIDERED

'93

FORM PTO-1449 U.S. DEPAF NT OF COMMERCE (REV. 7-85) PATENT AN MADEMARK OFFICE INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Sheet 2 f 2 ATTY. DO. 1 LA29 NP APPLICATION NO. 09/084,598 (0/080, 965 **APPLICANT** CHENG ET AL. **FILING DATE** SEPTEMBER 18, 2000 2/22/02 1614 16 26

Group

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLAS	TRAN	SLATION
65	AA	WO92/22533	12/23/92	PCT		S	YES	NO
	AB	EP0520723B1	6/1/94	Europe		+		
	AC	WO97/27847	8/7/97	PCT				
	AD	WO97/27857	8/7/97	PCT				H
	AE	WO97/28137	8/7/97	PCT			+	
	AF	WO97/28149	8/7/97	PCT			믐	
	AG	WO98/27974	7/2/98	PCT				
+	AH	WO99/07357	2/18/99	PCT			 -	<u></u>
	Al	WO99/08501	 			<u> </u>		
	 		2/25/99	PCT				므
	AJ	WO99/15520	4/1/99	PCT				
	AK	WO99/16758	4/8/99	PCT		<u> </u>	므	
	AL	WO99/20275	4/29/99	PCT			<u> </u>	
\bot	AM	WO 00/64876	11/2/00	PCT				
8	AN	WO 00/64888	11/2/00	PCT	<u> </u>			
	AO			<u></u>				
	AP							
	AQ							
	AR							
	AS							
	AT							
	AU							
	AV							
	AW							
	AX							
	AY				<u> </u>			
	AZ	_						
XAMIN	IER	GenalSach	200	DATE CONSIDERED	1/9/0	3	1 .	

*EXAMINER: Initial of reference considered, whether or not citation is in conformance with MPEP 609: Draw a line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.

FORM PTO-1449 (REV. 7-85) U.S. DEPATATION OF COMMERCE PATENT A ADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

(Us sev ral sheets if necessary)

Sheet 1 of 1

ATTY. DC

LA29 NP

APPLICATION NO.

09/664.599 /0/080, 965

APPLICANT

CHENG ET AL.

FILING DATE

GEPTEMBER 18, 2000 2/22/02



					·			ň <u>=</u>
			u.s.	PATENT DOCUMENTS		<u>.</u>		
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CL	ASS SUBCLA	ss /	ILING DATE
	AA		7					
-	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	АН							
	Al							
	AJ							
	AK							
	AL							
			FOREIG	ON PATENT DOCUMENTS		·		
		DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRAI	ISLATION NO
8	AM	WO 99/46232	9/16/99	PCT				
5	AN	WO 00/08002	2/17/00	PCT				
	AO							
	AP							
	AQ							
		OTHER DOC	UMENTS	(including Author, Title, Date, Pertine	ent pages, E	itc.)		
	AR							
	<u> </u>			· · · · · · · · · · · · · · · · · · ·		<u> </u>		
	AS							
	AT							·
EXAMIN	ER	Jun NSac	Pears	DATE CONSIDERED	1/9	103		<u> </u>

*EXAMINER: Initial of reference considered, whéther or not citation is in conformance with MPEP 609: Draw a line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.